

#### **GRAPHENE WAFER SCALE INTEGRATION**

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### Challenges

Graphene has allowed prototyping devices with exceptional performances and potentially huge impact in electronics, photonics and sensor

#### Goals

Set up required process modules on a wafer scale platform including encapsulation, contacting and patterning.

technology. The next big challenge is the wafer-scale integration, as success in real-world applications requires not only outstanding performance at the single-device level but also, large-scale fabrication processes.[1,2]

- Define a quality control protocol and ensure batch to batch reproducibility.
- Manufacture of needed units for the graphene imager product development and validation.

## Solution: Graphene Fabrication Technology on 150 mm Wafer Platform

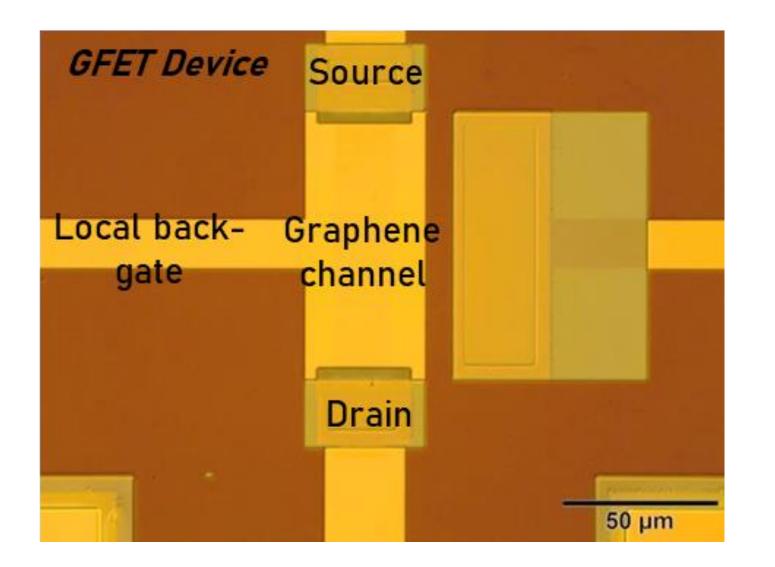
• Graphenea Large Scale Growth and Transfer

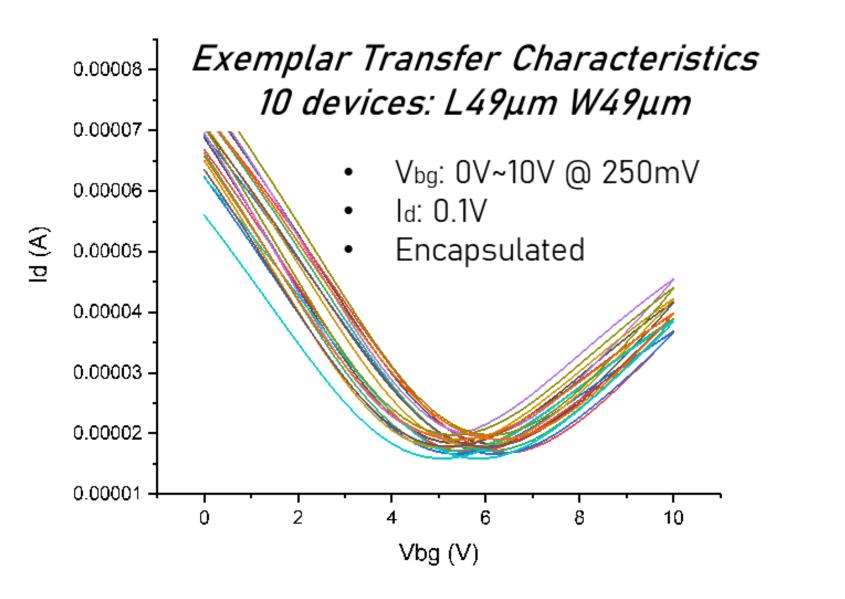
Graphene Wafer Scale Integration Platform \* 150 mm proof 200 mm scale-up compatible

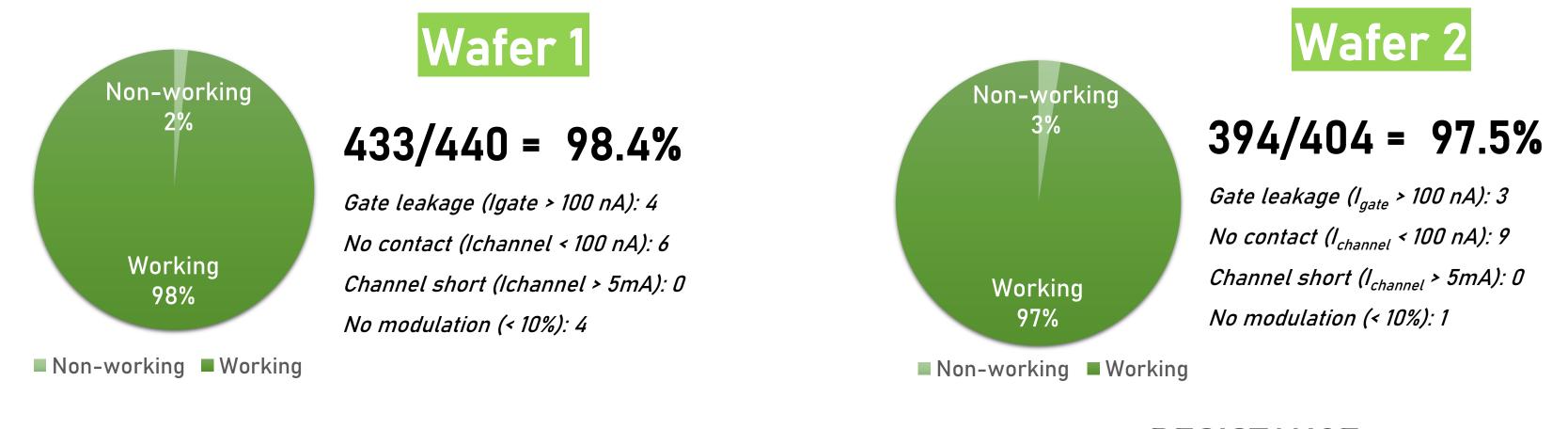
Graphene Foundry Process, including Patterning, AMO Contacting, Encapsulation

**EMBERION** Imager Functionalisation

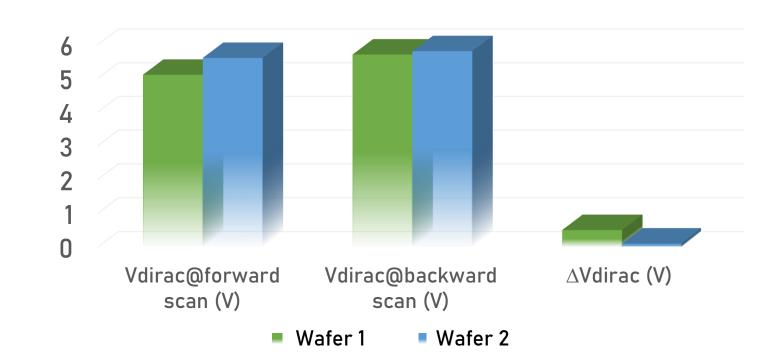
# **Results: 150 mm Wafer Statistics of Local Back-gated Graphene FETs**



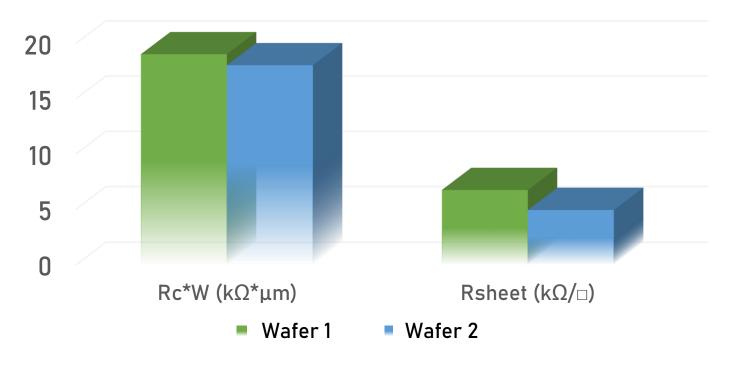




**DIRAC POINT AND HYSTERESIS** 







 $\checkmark$  Successful integration of graphene fabrication technology on 150 mm silicon wafer platform as a needed unit for a new graphene imager product

- ✓ Good batch-to-batch reproducibility, using semi-dry (wafer 1) and wet (wafer 2) transfer methods ✓ high device yield of 98%
- ✓ Mobility: 800–1000 cm2/Vs
- Promising for introduction of high-performing graphene-on-wafer at competitive cost, accelerating innovation for advanced 2DM-based electronics



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REFERENCES

[1] G. Fiori et al., Nat. Nanotechnol., 9 (2014) 768–779. [2] D. Neumaier, S. Pindl, M. C. Lemme, Nat. Mat., 18 (2019) 525–529.

